



Two-electron photo-excited atomic processes near inner-shell threshold studied by RIXS spectroscopy

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Single photon multi-electron excitations

straightforward manifestations of the breakdown of the independent electron picture as they appear due to the electron-electron interactions.



Multi-electron excitations can be studied by high-resolution X-ray measurements.





The main experimental problem hindering the study of near-threshold multi-electron excitations is the overlap of the shake-up, shake-off and double excitation spectral contributions.



MCDF calculated 1s3p - 3p² emission spectrum of Ar



An experimental method commonly used to study multielectronic excitations is near-edge photoabsorption on monoatomic gaseous targets

K edge of Ar:



FIG. 1. Near-K-edge photoabsorption spectrum of Ar. Zero energy is at the edge, $E_K=3206.26$ eV.

















High resolution x-ray spectrometer (HRXRS) at J. Stefan Institute

 \rightarrow cylindricaly bent crystal in Johansson geometry (R_{Rowland} = 50 cm)

Angular range: 30⁰ – 65⁰

 crystal
 refl. plane
 2d[Å]

 Quartz
 (110)
 8.5096

 Si
 (111)
 6.271

energy range 1.6 – 2.9 keV (3.2 - 5.8 keV) 2.2 – 4.0 keV



ightarrow diffracted photons are detected by the CCD camera (pixel size 22.5 x 22.5 μ m²)

Thermoelectricaly cooled BI CCD camera (ANDOR DX-438-BV) chip Marconi 555-20, 770x1152 pixels, pixel size 22,5 x 22,5 μ m² CCI-010 controler, readout frequency 1 MHz, 16bit AD conversion,

 \rightarrow spectrometer is enclosed in the 1,6 x 1,3 x 0,3 m³ stainless steel vacuum chamber working pressure: 10⁻⁶ mbar







1s3p and 1s2p double excitations in Ar:

ID26 beamline



- cryogenically cooled double Si(111) crystal monochromator
- energy resolution ~ 0.5 eV at the Ar K edge
- photon flux ~ 5x10¹² /s
- suppresion of higher harmonics by two Si mirrors
- \cdot beamsize 50(height) x 250(width) μ m²



- Target cell (12.5 mm Kapton windows) filled with 500 mbar of Ar
- Si(111) diffraction crystal
- \cdot energy resolution ~ 0.6 eV at the Ar KM line





Resonant Inelastic X-ray Scattering Workshop June 29th – July 1st 2009 / ESRF, Grenoble

HR KM X-ray line of Ar:

ESRF





K absorption edge of Ar:

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In this full RIXS plane a different character of separate multielectron contributions is clearly manifested!















Results of our MCDF calculated dipole oscillator strengths into [1s3p]nln'l' excited atomic states.

To represent excited states, the singlet P terms of eight configurations were mixed in the average level (AL) mode:

4p², 3d², 4s², 3d4s, 4p5p, 4s4d, 3d4d and 4d².

Calculations of single configuration energy levels provide only a tentative assignment of the main spectral features.

A precise theoretical description requires elaborate multiconfiguration energy and crosssection calculation, which takes into account correlations as well as the relaxation effects.

Ν	E [eV]	f x 10 ⁴	
1	3221.80	0.473	0.89 4s ² / 0.09 4p ²
2	3224.53	0.208	0.68 4p ² / 0.19 3d ²
3	3225.04	0.586	0.39 4s4d / 0.24 4p ²
4	3225.59	0.288	0.73 4s4d / 0.13 4p ²
5	3225.71	1.274	0.58 4s4d / 0.25 4p ²
6	3225.80	0.676	0.48 4s4d / 0.22 4p ²
7	3227.16	0.209	0.54 4p5p / 0.37 3d4d
8	3227.17	0.178	0.47 3d4d / 0.42 4p5p
9	3228.46	0.452	0.52 3d4d / 0.37 4p5p
10	3228.55	0.181	0.82 3d4d / 0.11 4p5p

PRL 102, 143001 (2009) PHYSICAL REVIEW LETTERS

week ending 10 APRIL 2009

Separation of Two-Electron Photoexcited Atomic Processes near the Inner-Shell Threshold

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[1s2p] double excitations:







A 2D RIXS map of [1s2p] doubly excited states:

















Conclusion:

- This work signs up RIXS as an important tool to study multielectron excitations in gaseous targets, with the potential that reaches beyond that of the absorption technique at least in two points:
 - effective experimental separation of multielectron excitations from the dominant single inner hole decay,
 - the energy resolution is not limited by energy width of the inner hole and the energy
- We are capable to perform high resolution RIXS studies of dilluted targets in a due time. Presented approach could be applied to other low density targets such as metallic vapors (involving open shell in the initial state), molecular targets (involving competitive decay channels, elaborated basis sets and structural effects) or gaseous targets in the external fields.

